# Guessing the geometric features of a particle trajectory in a magnetic field by measuring one point and its tangent 

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## Introduction: the geometrical issue

To determine the (~)helical trajectory of a charged particle in a uniform magnetic field (five parameters) the minimum information can be given by sampling one $\mathrm{R}-\phi$ projected helix point plus one 3D point and the measurement of its tangent direction.

To do so two/three detector layers are needed depending on the tangent measurement method.

All that follows from pure geometrical considerations but how it is feasible in a real tracker detector?

This issue can be the base for the development of the silicon trackers from the nowdays useful recorder systems of sensors to intelligent, practical sensor systems.

Less parameters we need more easy is to give "local" and quick responses.

## Introduction: the geometrical tangent

For the L1 trigger implementation it is of paramount importance that the radius $(\rho)$ and the origin of the helix are known in very short time ( $\sim 1 \mu \mathrm{~s}$ ).

The knowledge of the tangent direction (R-Ф projection) can be a good approach to the problem. In case the tracks come only from the interaction point (primary vertex) the discrimination of the tangent inclination allows the fast selection of high pTs. But in the real world the tangent inclination parameter selects also non primary particles of unpredictable pTs (e+e-, compton, secondary interactions,... ) while still working correctly with primary tracks.

The measurement of one 3D point and its tangent gives a guess on the track $\mathrm{P}^{\mathrm{T}}$ because of the background haze, the certainty is reached only by correlations with few other detector layers. This assertion gives a first rough definition of the "local" concept.

The barrel region : basic scheme of the "stacked layer" and "Cluster Width" approaches
Stub R- $\Phi$ components
$\Delta$ (device effective thickness)
$\mathrm{TW}=\mathrm{f}\left(\mathrm{p}_{\mathrm{T}, . .}\right) \Delta$
$T Z=g\left(p_{\|} / p_{T}, ..\right) \Delta$


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## The Stub Width measurement



| $\mathbf{n}=\boldsymbol{\operatorname { l n }}(\mathbf{w} / \mathbf{p})$ | fired strip probability (TW ${ }_{\text {meas }}$ ) |  |  |  |
| :---: | :--- | :--- | :--- | :--- |
|  | $\mathbf{N}=\mathbf{1}$ | $\mathbf{N}=\mathbf{2}$ | $\mathbf{N}=\mathbf{3}$ | $\mathbf{N}=\mathbf{4}$ |
| 0 | $1-w / p$ | $w / p$ | 0 | 0 |
| 1 | 0 | $2-w / p$ | $w / p-1$ | 0 |
| 2 | 0 | 0 | $3-w / p$ | $w / p-2$ |

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TW : formulas and approximations (tracks from $Z$ axis)
$T W_{r}=T W / \Delta \approx f\left(p T^{*}, X / R\right)$
"reduced" TW

$$
\begin{aligned}
& p T_{\text {min }}(\mathrm{GeV} / \mathrm{c})=0.3 \mathrm{~B}(\mathrm{~T}) R(\mathrm{~m}) / 2==C M S \Rightarrow 0.6 \mathrm{R}(\mathrm{~m}) \\
& \mathrm{pT}^{*}=\mathrm{pT} / \mathrm{p}_{\text {min }} \text { "reduced" } \mathrm{pT}
\end{aligned}
$$

The scale factors allow a very synthetic description of Stub Widths With $W / R<0.2$ (angular acceptance), $\mathrm{P}^{*}>$ few units $f\left(p T^{*}, X / R\right)$ is linear

$$
T W_{r} \approx \pm\left(\frac{p T_{\min }}{p T}\right)+x / R= \pm 1 / p T^{*}+x / R
$$

cylindrical layer
(pT* any)

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## Lorentz spread compensation

The magnetic field effects on the signal charges inside the sensors produce a constant spread of TWs depending on the carriers $\left(\theta_{\mathrm{L}}\right)$ and on the active thickness of the
detector :

$$
T W_{r}=\approx f\left(p T / p T_{\min }, X / R\right)+(2 D / \Delta) \tan \theta_{L}
$$

$2 D$ is the effective path covered by the signal charges. In the single sensor case $2 D=\Delta$, in the stacked case 2 D is the full Si thickness or less. It depends on the relative position of the electrode meshes.
general equation for the "linear" approx.

$$
T W_{r} \approx \pm\left(\frac{0.6 R \cos \alpha}{p T}\right)+\tan \alpha+\frac{X}{R \cos \alpha}+(2 D / \Delta) \tan \theta_{L}
$$


$2 D=\Delta: \alpha=-\theta_{\mathrm{L}} \quad 2 \mathrm{D}<\Delta: \tan \alpha=-\frac{2 D}{\Delta} \tan \theta_{L}$
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## TW measurements

reduced momentum $\mathrm{pT}^{*} \geq 3$
R- $\Phi$ acceptance $\mathrm{W} / \mathrm{R}$ < 0.2
full Lorentz compensation
$\left(\frac{T W}{\text { pitch }}=T W_{r} \frac{\Delta}{\text { pitch }} \approx\left( \pm\left(\frac{1}{p T^{*}}\right)+\frac{X}{R^{\prime}}+\tan \alpha+12 D / \Delta\right) \tan \theta_{L}\right)_{\text {rotation }}^{\text {pitch }}$ Toreal layer
ToP (Thickness over Pitch) is the new scale factor for the measurement amplitude

Real world : charge diffusion and capacitive coupling add a constant (w0 $\leq 1$ ) which can depend on the amplitude discrimination of signals.

Lorentz angle (also $\Delta$ ) varies with aging and it can be recovered tuning the bias voltage

## pT selection : only $1 / p T^{*}$ term

Setting $N$ strips as an upper limit (cut), the $100 \%$ efficiency of selection is achieved at

$$
\left.p T^{*}\right|_{100 \%} \approx \frac{1}{N-2} \times \frac{\Delta}{\text { pitch }}
$$

while the full exclusion (0\% efficiency) is either at or below

$$
\left.p T^{*}\right|_{0 \%} \approx \frac{1}{N-1} \times \frac{\Delta}{\text { pitch }}
$$

In the range

$$
\Delta p T^{*}=\frac{2}{(N-1)(N-2)} \times \frac{\Delta}{p i t c h} \quad \text { efficiency varies from } 0 \% \text { to } 100 \%
$$

$p T^{*}$ threshold increases with ToP and decreases with increasing $N$.
$N=3$ is the minimum value to reach $100 \%$ efficiency within a finite $p^{\top}$ range
Real world: $\mathrm{N}-$-> $\approx \mathrm{N}-\mathrm{w} 0$

## Selection efficiencies: $1 / \mathrm{p} T^{*}$ term

Numerically computed data confirm the formulas. Small discrepancies at $p T^{*} \approx$ few units. Computation has been made with very small angular acceptance $\left(X / R^{\prime} \ll 1\right)$

For practical cases use $0.6 R(m) \times p T^{*}$
(4 T magnetic field)

At $\mathrm{p}^{*}$ > few units (linear approx.) curves are described by eff $\approx(N-1)-T o P / p T^{*}$


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## The barrel layout: primary Background

To estimate the PT threshold to reduce the minimum bias rate I compare the selection curves with the flux obtained ( $4 \times 10^{4}$ particles $/ 4 \pi / B X$ ) in a 4 T magnetic field at $\eta \approx 0$.


## The detector layout: secondary background

Big issue, not to exhaust in a couple of slides!
Electrons, nuclear interactions,.. have an unpredictable origin.
The Stub widths they produce are

$$
\begin{equation*}
T W_{r} \approx \pm\left(\frac{0.6 R_{b}}{p T^{\prime}}\right)+\frac{X-X_{0}}{R_{b}} \tag{Lorentzspreadcompensated?}
\end{equation*}
$$

$R_{b}, X_{0}$ are the origin coordinates wrt the detector of the particle with $p T^{\prime}$ momentum.

If particles are generated at $\mathrm{R}^{\prime}$ from the detector their $\mathrm{pT}^{\prime}$ upper limit is

$$
p T^{\prime} \leq \frac{N-2}{N-1} \times \frac{R_{b}}{R_{0}} \times p T_{100 \%} \quad\left(p T^{\prime} \leq \frac{1}{2} \times \frac{R_{b}}{R_{0}} \times p T_{100 \%}\right) \longleftarrow \mathrm{N}=3
$$

The $p T^{\prime}$ limit decreases with the approaching of the origin to the detector ( $R^{\prime}->0$ ) and increases with the increasing of the threshold of the primary particles.

Can these simple remarks imply some constraints for the layout? e.g.the spacings between successive layers which should not be equals.

## Selection efficiency: including the $X / R^{\prime}$ term

When $X / R^{\prime} \approx 1 / P T^{*}$ the simple width discrimination fails (angular acceptance $\cong 1 / p T^{*}$ threshold, High thresholds and large acceptances)


$\mathrm{N}=3$, Lorentz compensated
detectors are divided into 10 regions $A, B, . ., I$ single region efficiencies are divided by charge sign and normalized to the total number of particles


## The $\mathrm{X} / \mathrm{R}$ mapping (on detector)

Two possibilities for the rounding of the $X / R$ correction: up to the next integer (Excess approximation), down to the nearest integer (Defect approximation).
A few concerns about the homogeneity of the selection remain.
$100 \%$ threshold is higher.

$$
\mathrm{ToP}=40, \mathrm{~N}=3
$$


no corrections

correction map (excess approx.)

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The endcap region : slabs normal to $Z$

$$
\frac{T W}{R}=-\frac{\Delta}{Z} \sin ^{-1}\left(\frac{p_{T \text { min }}}{p_{T}}\right)
$$

$$
\begin{aligned}
& p_{T \min }=0.6 R \\
& (B=4 \mathrm{~T}, \mathrm{R}(\mathrm{~m}))
\end{aligned}
$$

No "tile" effects
(but $R$ is not constant)

No Lorentz drift
Stub

## Stub width measurements

$\frac{T W}{\text { pitch }} \approx-\frac{\Delta}{\text { pitch }} \frac{R}{Z} \frac{p_{T \text { min }}}{p_{T}}$

For $\mathrm{pT}^{\top} \geq 0.5 \mathrm{p}_{\text {Tmin }}$

Similar to the barrel case with small acceptance sensors and no Lorentz drift. $R\left(p T_{\text {min }}\right)$ varies from point to point on all the disk plane.

Some attention is required for the sensor segmentation (strips, ministrip,..). The proper strip symmetry is radial, but with $<10 \times 10 \mathrm{~cm}^{2}$ detectors a parallel symmetry should introduce acceptable distortions at $R \geq 50 \mathrm{~cm}$ or less. In the following I assume a constant ratio $\Delta /$ pitch (ToP) as in barrel case

$$
\frac{T W}{\text { pitch }} \approx-\frac{\Delta}{\text { pitch }} f \frac{1}{p_{T}{ }^{*}} \quad, \quad f=\frac{R}{Z}
$$

## pT selection threshold

As in the barrel case, the stub widths < $N$ give $\mathrm{p}^{\top}$ selections of the type:

$$
\begin{aligned}
& \left.\left.p T^{*}\right|_{100 \%} \Rightarrow p T\right|_{100 \%} \approx \frac{1}{N-2} \times \frac{\Delta}{\text { pitch }} \times f \times p T_{\min } \\
& \left.\left.p T^{*}\right|_{0 \%} \Rightarrow p T\right|_{0 \%} \approx \frac{1}{N-1} \times \frac{\Delta}{\text { pitch }} \times f \times p T_{\min }
\end{aligned}
$$

$f=R / Z$ is usually $<1$ and and hence higher ToPs are needed to perform PT cuts similar to those of the barrel.

To keep about the same pT threshold ToP must be changed from disk to disk and from ring to ring.

PT thresholds vary inside the detector from $\mathrm{R}_{\mathrm{IN}}$ to $\mathrm{R}_{\mathrm{EXT}}$ and we expect that efficiency curves are less steep than those in barrel detectors.

## Disk at $Z=2.65 \mathrm{~m}, 83 \mathrm{~cm} \leq R \leq 96 \mathrm{~cm}, \mathrm{ToP}=20, \mathrm{~N}=3$



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## The general case of inclined slabs

$$
\begin{aligned}
T W & \approx-\Delta \frac{0.6}{p_{T}} \frac{R^{2}}{Z \cos \gamma+R \sin \gamma} \\
T W & \approx-\Delta \frac{0.6}{p_{T}} R_{e q} \\
R_{e q} & =\frac{R^{2}}{Z \cos \gamma+R \sin \gamma}
\end{aligned}
$$

"tile" and Lorentz drift effects not taken into account.... ...but smaller than in the barrel case

R-Z map ( $10 \times 10 \mathrm{~cm}^{2}$ ) : disc/barrel like geometry (not a layout proposal)

$$
\text { pTth100\% }=\text { ToP } \times 0.6 \text { Req }, T W \leq 2 \text { strip }(N=3)
$$

Within each region (8), same detectors and same $\mathrm{p}^{T}$ threshold.
Req (m)
Same threshold for all the tracker with $\approx 6$ different ToPs

| - | 1.1 |
| :--- | :--- |
| - | 0.6 |
| - | 1.1 |
| - | 0.30 |
| - | 0.64 |
| - | 0.21 |
| - | 0.49 |
| - | 0.15 |



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Disk 7 , rings \#10, 8, 4 (ref. R.Frazier) cut at $N=3$

modules of the $4^{\text {th }}$ ring with the ToP of the $8^{\text {th }}, 10^{\text {th }}$ rings are tilted in R-Z
\#4 has twice the ToP of \#8, \#IO \#4' the same ToP


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## Discussion I

The measurement of pTs of tracks crossing a single detector of the tracker can be done directly by measuring the "stub" R- $\Phi$ widths produced. This is true for tracks coming from primary vertex. To avoid spurious triggers correlations one can use additional information coming from nearby detectors. The main characteristic of the stub width is the proportionality to $1 /$ PT $^{2}$ and its scalability with the detector position and geometry.

Tile geometry of the sensors and Lorentz drift can affect the selection introducing perturbations of the $1 / \mathrm{pT}$ behavior which depends on the geometry of the layout.

Inside the same detector layout the scale factors depend on the position of the detector and on its structural "thickness-over-pitch" (ToP) specs. Several R\&D activities are investigating the convenient ToP values to be used for the PT selection as well as the best way of obtaining them.

The non primary background suggests to correlate pT selections on different tracker layers. That could require the use of similar $\mathrm{p}^{T}$ thresholds and hence different ToPs since thresholds depend on the radial position as well as on $Z$ position (endcaps).

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## Discussion II

The layouts usually considered are the barrel geometry, mostly in the central region, and the disc geometry at the end caps of the tracker. In this presentation I pointed out that in a variable layout scheme the radial and $Z$ dependance of the $p T$ threshold can be compensated by a suitable inclination of the detector with respect the $Z$ axis. This method should allow to have same PT threshold in wider regions of the tracker simply exploiting sensors with the same ToP.

The cons of this approach must be evaluated. Effects due to the finite sensor tiles, to the primary interaction vertex spread, etc. must be investigated. Mechanics issues may play an important role too.

If all these cons were "easily" surmountable, selections based on correlations among different (R- $\Phi$ ) sensors would be facilitated.

## Backup

## abstract

The talk reviews the geometric basis of the "PT" and "CW" approaches for the selection of high transverse momentum particles coming from primary interactions at sLHC. Starting from the definition of a small segment measurement (stub) of a particle trajectory it gives basic general constraints which contour the architecture of both methods. The sensor position with respect to the production vertex as well as the sensor structure and design are key factors the behavior of which is described by a-dimensional parameters according simple scaling laws. Using these tools the selection efficiency of high transverse momentum is discussed in a thorough way, with emphasis to the effects due to the Lorentz drift, non primary background particles, sensor dimension and position. The discussed predictions, while waiting the LHC collisions validation, can be verified with the cosmic rays data in the CMS Tracker.

## Measurements of the Helix parameters

3 D sample ( $\infty^{1}$ solutions)
$\left(X_{1}, Y_{1}, Z_{1}\right)$ :
two equations

$$
\begin{aligned}
& \left(X_{1}-X_{0}\right)=\rho \cos \left(2 \pi \frac{Z_{1}-Z_{0}}{p}\right) \\
& \left(Y_{1}-Y_{0}\right)=\rho \sin \left(2 \pi \frac{Z_{1}-Z_{0}}{p}\right)
\end{aligned}
$$

geom. tangent $\left(X_{1}, Y_{1}, Z_{1}\right)$ : two equations

$$
\begin{aligned}
& \frac{d x}{d z}=-2 \pi \frac{\rho}{p} \sin \left(2 \pi \frac{Z_{1}-Z_{0}}{p}\right) \\
& \frac{d x}{d z}=2 \pi \frac{\rho}{p} \cos \left(2 \pi \frac{Z_{1}-Z_{0}}{p}\right)
\end{aligned}
$$

2 D sample (R- $\phi$ projections) ( $\infty^{3}$ solutions)

$$
\begin{aligned}
& \left(X_{1}, Y_{1}\right): \\
& \text { one equation }
\end{aligned}
$$

$$
\left(X_{1}-X_{0}\right)^{2}+\left(Y_{1}-Y_{0}\right)^{2}=\rho^{2}
$$

geom. tangent ( $X_{1}, Y_{1}$ ): one equation

$$
\frac{d y}{d x}=-\left(\frac{X_{1}-X_{0}}{\rho}\right) \frac{1}{\sqrt{1-\left(\frac{X_{1}-X_{0}}{\rho}\right)^{2}}}
$$

## Data rate in Barrel - I (F.Palla)



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## The "stub" width (TW)

Dependence on detector parameters and on the curvature of the helix quite complicate.
If $\mathrm{TW}^{2}+\Delta^{2} \ll \rho_{\text {track }}{ }^{2}$
opposite charge MIPs


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## compensation by rotation



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## High thresholds : the map of the detector

Large acceptances require to map the detector by subtracting the $X / R$ term. This is possible in the stacked detectors where the sign of stubs is known.

Two possibilities for the rounding of the $X / R$ correction: up to the next integer (Excess approximation), down to the nearest integer (Defect approximation). Few concerns about the homogeneity of the selection remain. $100 \%$ threshold is higher.


## Selection efficiency and the Lorentz compensation

 In the stacked detectors the Lorentz spread can be compensated either mapping or rotating the detector. The necessity of the compensation is important in case the signals are generated by electrons ( $\theta_{\mathrm{L}} \approx 23^{\circ}$ ).The Lorentz spread impacts uniformly on all the detector. Particularly critical are the side areas where the acceptance perturbations are stronger.


## Lorentz Compensation by tilting : single sensor

$$
\begin{aligned}
W / R & =0.1 \\
N & =3 \\
\theta_{L} & =6^{\circ} \\
\alpha & =-6^{\circ}
\end{aligned}
$$

High thresholds high distortions and good compensation (but acceptance effects)


## Cylindric helix trajectory

$$
\begin{aligned}
& \mathrm{p}_{\mathrm{T}}(\mathrm{GeV} / \mathrm{c})=1.2 \rho(\mathrm{~m}) \\
& \mathrm{passo} / \rho=2 \pi \mathrm{pII} / \mathrm{p}_{T}
\end{aligned}
$$

$R=2 \rho \sin \phi$
$=\left(p_{T} / 0.6\right) \sin \left(0.6 \mathrm{z} / \mathrm{pl}_{\|}\right)$
$\approx\left(p_{T} / p_{\|}\right) z$

$$
\frac{W_{R \Phi}}{R}=-\frac{\Delta Z}{Z} \sin ^{-1}\left(\frac{p_{T \min }}{p_{T}}\right)
$$

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## sensor plane with $\gamma$ gradient

$$
W_{R \Phi(\text { incl })}=-\Delta \frac{\sin (\phi)}{(p / 2 \pi \rho) \cos \gamma+\sin \gamma \cos \phi}
$$

$$
W_{R \Phi(\text { incl })} \approx-\Delta \frac{0.6}{p_{T}} \frac{R^{2}}{Z \cos \gamma+R \sin \gamma}
$$

$$
\begin{aligned}
& W_{R \Phi(\text { incl })} \approx-\Delta \frac{0.6 R_{e q}}{p_{T}} \\
& R_{e q}=\frac{R^{2}}{Z \cos \gamma+R \sin \gamma}
\end{aligned}
$$

R-Z map ( $10 \times 10 \mathrm{~cm}^{2}$ ) : barrel geometry
$\mathrm{pTth} / \mathrm{ToP} \geq f(\mathrm{GeV} / \mathrm{c}) \approx 0.6 \mathrm{R}$
f
$\geq 1.1$
$\bigcirc \geq 1$
$O \geq 0.9$
$0 \geq 0.8$
$0 \geq 0.7$
$0 \geq 0.6$
$0 \geq 0.5$
$\circ \geq 0.4$

- $\geq 0.3$
$-\geq 0.2$
.$\geq 0.1$
$<0.1$

PTth(100\%) $=$ ToP $\times f, C W \leq 2$ strips


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$\bigcirc \geq 1.1$
$\bigcirc \geq 1$
$O \geq 0.9$
$0 \geq 0.8$
$0 \geq 0.7$
$0 \geq 0.6$
$0 \geq 0.5$
$\circ \geq 0.4$

- $\geq 0.3$
$-\geq 0.2$
$\cdot \geq 0.1$
- < 0.1

R-Z map ( $10 \times 10 \mathrm{~cm}^{2}$ ) : disc geometry
$\mathrm{pTth} / \mathrm{ToP} \geq \mathrm{f}(\mathrm{GeV} / \mathrm{c}) \approx 0.6 \mathrm{R}^{2} / \mathrm{Z}$


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R-Z map ( $10 \times 10 \mathrm{~cm}^{2}$ ) : disc/barrel like geometry $\mathrm{pTth} / \mathrm{ToP} \geq f(\mathrm{GeV} / \mathrm{c}) \approx 0.6 \times 1.1$

$$
\text { pTth100\% }=\text { ToP } \times f \quad, C W \leq 2 \text { strip }
$$



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